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# **Distributed Utility Integration Test (DUIT): Facility and Unintentional Islanding Results**

## **Distributed Utility Associates**

**DOE High-Tech Inverter Workshop  
Radisson Cross Key Hotel,  
Baltimore MD, October 13-14, 2004**

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# The DUIT Facility

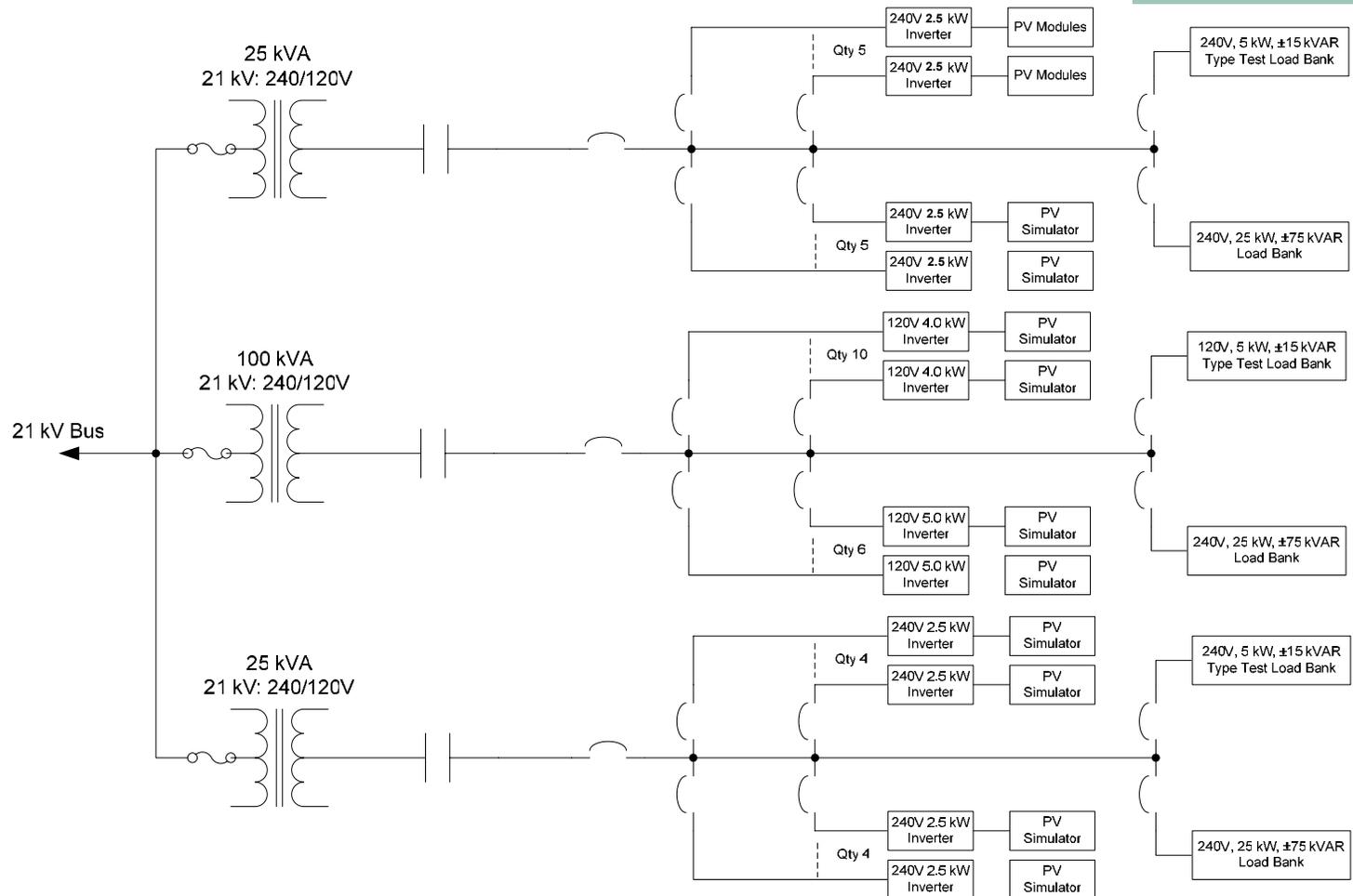
## Overview

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- Unique research facility for evaluating grid impacts of commercial-grade Distributed Resources (DR)
  - Islanding
  - Power Quality
  - Sectionalizing
  - Short Circuit Contribution
  - Stability
  - Voltage Regulation
  - Reclosing Coordination
  - Fuse Coordination
  - Capacitor Switching
  - Adjacent Feeder Faults
- Wide and growing range of both inverter-based and rotating machine-based technologies, all selected based on current and potential market impact
- Includes three classes of equipment (as of 6/04)
  - Residential (single-phase,  $\leq 5$  kW)
  - Commercial (three-phase, 30 kW to 250 kW)
  - Industrial (three-phase,  $\geq 250$  kW)

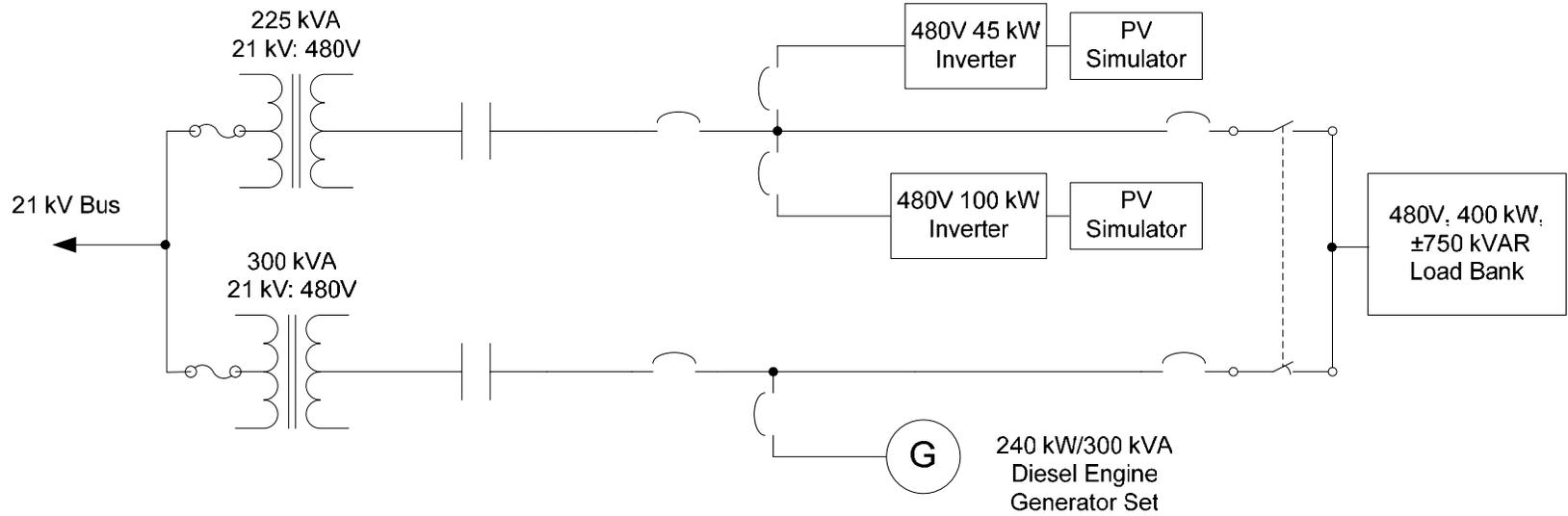
# Single Line Diagram

## Bay 1



# Single Line Diagrams

## Bay 2 and 3



# The DUIT Facility

## Bay 1 – Residential DR

- Distributed Resources
  - 2.5 kW, 240 VAC, 1-ph PV Inverters (10)
  - 4.0 kW, 120 VAC, 1-ph Battery-Based Inverters (10)
  - 2.5 kW, 240 VAC, 1-ph PV Inverters (8)
  - 5.0 kW, 120 VAC, 1-ph Battery-Based Inverters (6)
- Power Sources
  - 12.5 kW PV Array
  - Various power supplies rated from 60VDC to 600VDC at power ratings to 6 kW



- Load Banks
  - 120V & 240V “Type Test” load banks, 5 kW/±15 kVAR each, independent variac control on R, L and C
  - Three 25 kW/±75 kVAR load banks for multi-unit testing

# The DUIT Facility

## Bay 2 – Commercial DR

- Distributed Resources
  - 100 kW, 480V 3-ph PV Inverter
  - 45 kW, 480V 3-ph PV Inverter
- Power Sources
  - PV Simulator (Power Supply)
  - 300 to 600VDC, 2x300ADC
- Load Bank
  - 400 kW of resistive load, 750 kVAR each of inductive and capacitive load
  - Coarse control through discrete steps of R, L, C
  - Fine control through variacs on 25 kW of resistance, 25 kVAR of capacitance



# The DUIT Facility

## Bay 3 – Industrial DR

- Distributed Resource
  - 240 kW, 300 kVA, 480V 3-phase diesel engine-driven synchronous generator



- Load Bank
  - Shares 400 kW and  $\pm 750$  kVAR load with Bay 2

# The DUIT Facility

## Medium Voltage Distribution System



- Each bay tied into PG&E medium voltage distribution system via one or more pole-mount transformers

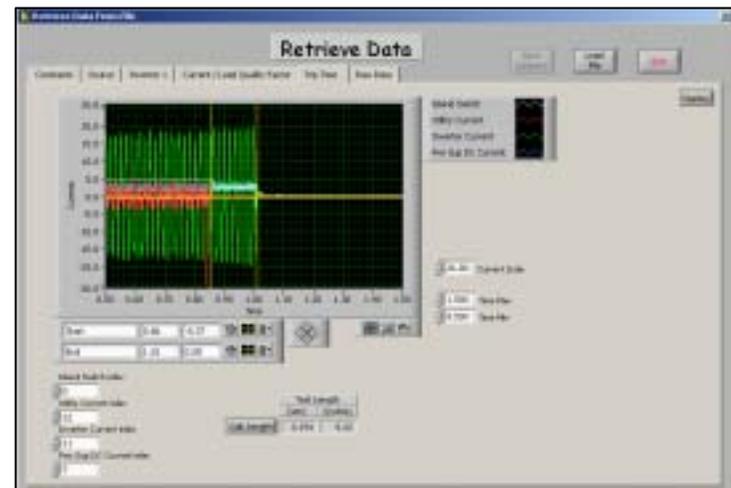
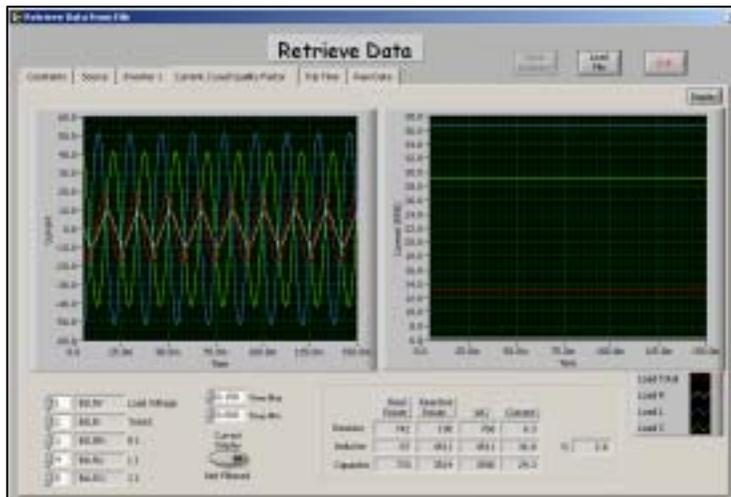
- 21 kV motor-operated load break switch allows for isolation of total DUIT facility from grid



# The DUIT Facility

## Data Acquisition and Control System

- National Instruments LabView™ based system
- 6 kHz sampled data collected for voltage and current at every relevant node in system for each test



Anti-Islanding Test Plan	Test Description and Sequence
6.1	<i>Basic Islanding Test</i> Individual unit testing
6.2	<i>Islanding with Multiple DRs</i> Homogeneous Groups Small Groups Progressions
6.3	<i>Non-Linear Loads, Anti-islanding Tests</i> Individual Units
6.4	<i>Islanding with Dynamic Load: Generation Ratios</i> Individual Units
6.5	<i>Anti-islanding with Rotating Loads</i> Individual Units
6.6	<i>Harmonic Content due to Anti-islanding Schemes</i> Individual Units
6.7	<i>Voltage/Frequency Trip Settings</i> Individual Units Homogeneous Groups Small Groups Progressions

# Single Unit Islanding Test Procedure

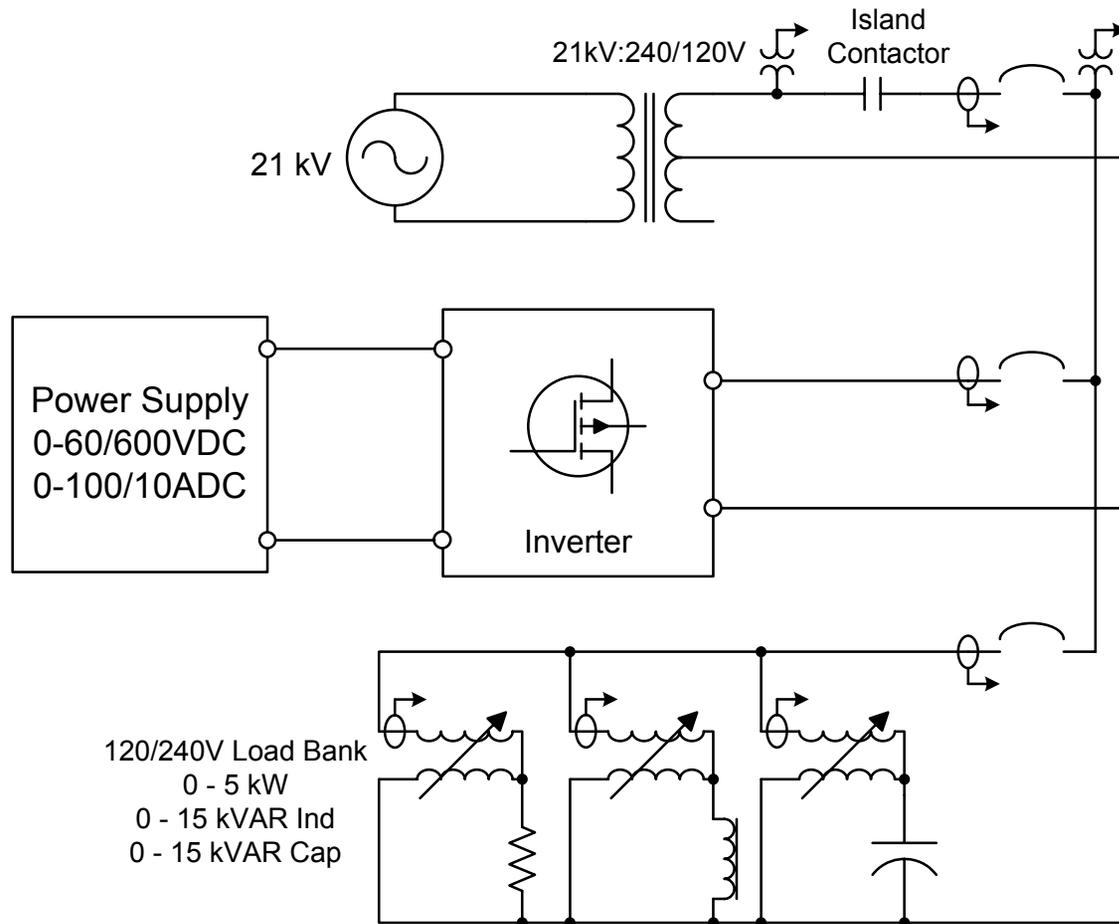
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- “Basic” anti-islanding tests (DUIT Test Protocol 6.1) performed on a single unit for each DR model (two single units for single phase inverters)
- IEEE 1547/UL 1741/CA Rule 21 procedures
- Main purposes:
  - “Ring out” test setup and data acquisition in preparation for multi-unit islanding tests
  - Ensure test setup produces consistent results from unit to unit
  - Gain an understanding of manufacturers’ anti-islanding methods to select appropriate combinations for multi-unit testing

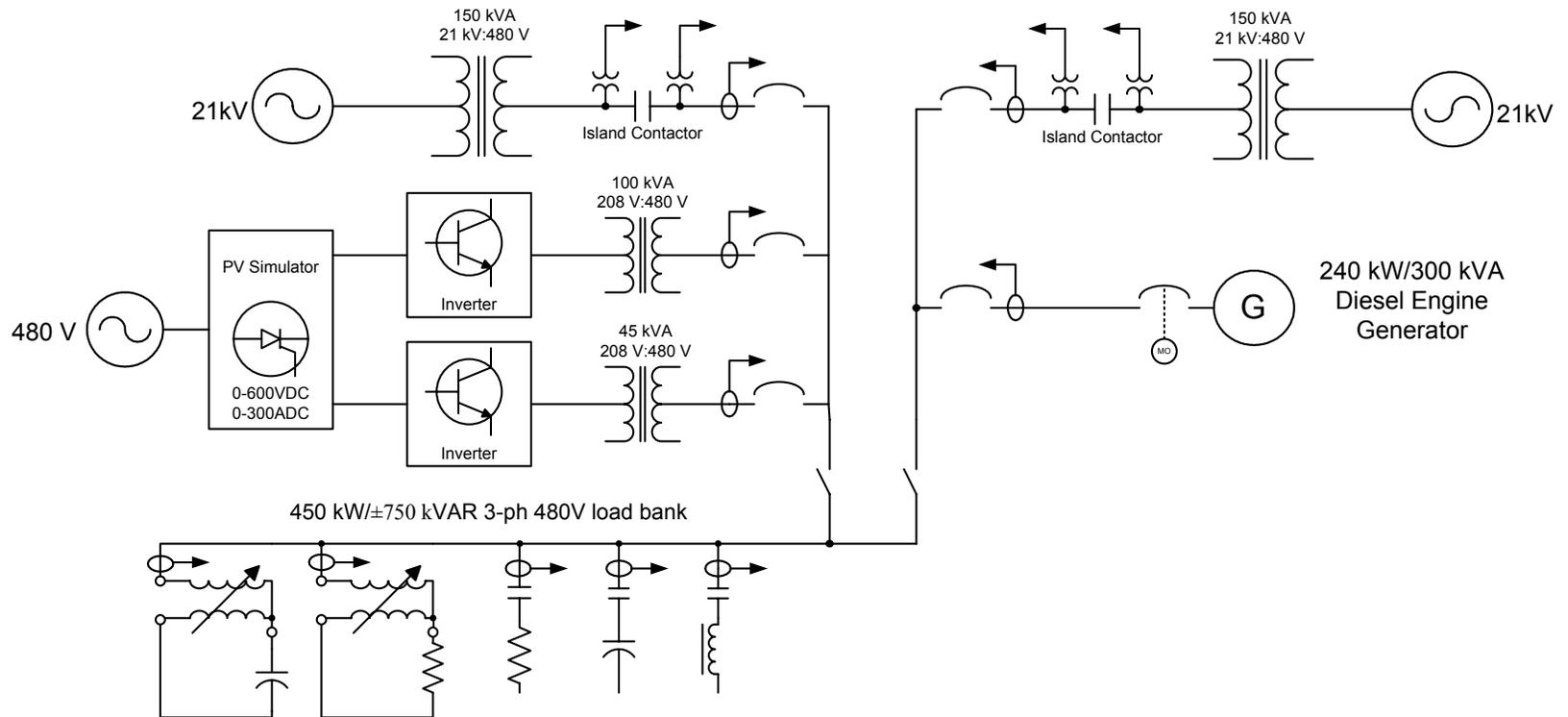
# Single Unit Islanding Test Procedure

- Measure DR shutdown times under three generation/load conditions
  - $P_{\text{gen}} = 25\%$ ,  $P_{\text{load}} = 25\%$
  - $P_{\text{gen}} = 50\%$ ,  $P_{\text{load}} = 50\%$
  - $P_{\text{gen}} = 100\%$ ,  $P_{\text{load}} = 100\%$
- In each case, inductive and capacitive loads are adjusted to resonant frequency of 60 Hz with quality factor (Q) of 2.5 for first test
- L or C is adjusted in steps of 1% between -5% and +5% of nominal value used in first test
- Results in a total of 33 tests per DR

# Single Phase Test Setup



# Three Phase Test Setup



# Retrieve Data

 Save  
summary

 Load  
File

Exit

Constants

Source

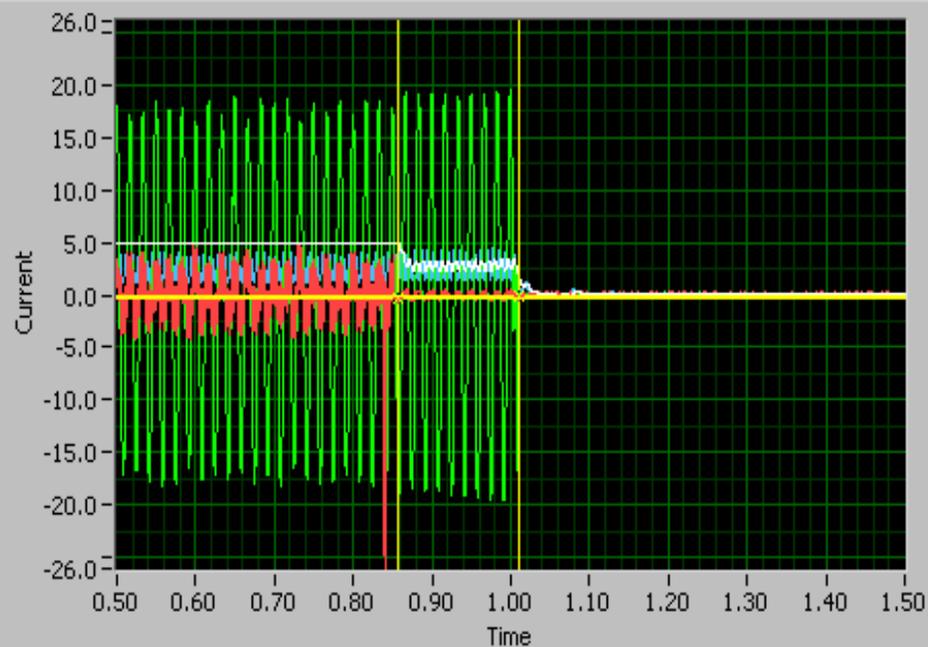
Inverter 1

Current / Load Quality Factor

Trip Time

Raw Data

Display



Island Switch



Utility Current



Inverter Current



Pwr Sup DC Current



26.00 Current Scale

1.500 Time Max

0.500 Time Min

Start 0.86 -0.37



End 1.01 0.00



Island Switch index

0

Utility Current index

12

Inverter Current index

11

Pwr Sup DC Current index

7

Test Length

(sec) (cycles)

Calc Length

0.154

9.22

# Single Unit Islanding Test Results

## Bay 2, Initial Testing

<b>Device</b>	<b>Mean Trip Time</b>	<b>Median Trip Time</b>	<b>Standard Deviation</b>	<b>Trip Times &gt; 2 seconds</b>	<b>Longest Trip Time</b>
<b>Device E</b>	<b>0.12 s</b>	<b>0.10 s</b>	<b>0.05 s</b>	<b>0 of 33</b>	<b>0.39 s</b>
<b>Device F</b>	<b>0.26 s</b>	<b>0.20 s</b>	<b>0.23 s</b>	<b>0 of 33</b>	<b>1.16 s</b>

# Single Unit Islanding Test Results

## Bay 3, Initial Testing

<b>Device</b>	<b>Mean Trip Time</b>	<b>Median Trip Time</b>	<b>Standard Deviation</b>	<b>Trip Times &gt; 2 seconds</b>	<b>Longest Trip Time</b>
<b>Device G*</b>	<b>1.27 s</b>	<b>0.99 s</b>	<b>0.66 s</b>	<b>5 of 40</b>	<b>3.33 s</b>

\* This device includes external anti-islanding controls that have not yet been NRTL-certified to UL.

# Single Unit Islanding Test Results

## Bay 1, Initial Testing

<b>Device</b>	<b>Mean Trip Time</b>	<b>Median Trip Time</b>	<b>Standard Deviation</b>	<b>Trip Times &gt; 2 seconds</b>	<b>Longest Trip Time</b>
<b>A</b>	<b>0.34 s</b>	<b>0.34s</b>	<b>0.08 s</b>	<b>0 of 66</b>	<b>0.55 s</b>
<b>B</b>	<b>0.27 s</b>	<b>0.09 s</b>	<b>0.48 s</b>	<b>1 of 66</b>	<b>3.31 s</b>
<b>C</b>	<b>0.14 s</b>	<b>0.06 s</b>	<b>0.23 s</b>	<b>0 of 66</b>	<b>1.16 s</b>
<b>D</b>	<b>0.20 s</b>	<b>0.08 s</b>	<b>0.35 s</b>	<b>1 of 66</b>	<b>2.22 s</b>

# Single Unit Islanding Test Results

## Bay 1, Supplementary Testing

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- Device B
  - Longest run-on in initial testing occurred at rated power; inverter operating in power limiting mode
  - Supplemental testing with device at power limit and DC input voltage near minimum of operating range resulted in some trip times exceeding 10 seconds with well-tuned load
- Device C
  - When power levels were decreased from 27% to 24% of device rating, run-ons in excess of 30 seconds were observed.
- Device D
  - Power limiting in initial testing achieved through changing inverter setpoints, consistent with UL methods
  - Supplemental testing performed by lowering input voltage to effect DC current limiting for achieving partial load points; some run-on times in excess of 30 seconds were observed with well-tuned load

# Single Unit Islanding Test Results

## Resulting Follow-On Actions

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- Recommended revisions to UL1741:
  - 1) Manufacturer to provide details of anti-islanding algorithm, or 2) device to be subjected to islanding tests in center and limits of input voltage window
  - 5% load (quadruples # of test points)
  - More explicit language regarding:
    - Definition of balanced test conditions
    - Test load linearity
    - Tolerances on pre-test voltage and frequency
    - Accounting for parasitic losses (real and reactive)

Anti-Islanding Test Plan	Test Description and Sequence
6.1	<i>Basic Islanding Test</i> Individual unit testing <span data-bbox="1370 171 1485 257" style="color: red; font-weight: bold; transform: rotate(-15deg);">Done</span>
6.2	<i>Islanding with Multiple DRs</i> Homogeneous Groups Small Groups Progressions <span data-bbox="1370 328 1618 485" style="color: red; font-weight: bold; transform: rotate(-15deg);">In Progress</span>
6.3	<i>Non-Linear Loads, Anti-islanding Tests</i> Individual Units
6.4	<i>Islanding with Dynamic Load: Generation Ratios</i> Individual Units
6.5	<i>Anti-islanding with Rotating Loads</i> Individual Units
6.6	<i>Harmonic Content due to Anti-islanding Schemes</i> Individual Units
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# Distribution System Impact Study

**Initial study performed to look at the probability of necessary conditions for an islanding event to occur**

<b>I Static P, Q balance</b>	<b>0.001 to 0.01 per event (High penetration) 1E-10 to 1E-8 per event (Low penetration)</b>
<b>II Resonant Frequency</b>	<b>1E-5 to 1E-2 per year</b>
<b>III Fault events</b>	<b>0.15 to 0.3 per year</b>
<b>IV Time domain stability</b>	<b>0.1 per year</b>

***All conditions are statistically independent***

***High penetration: 1.5E-10 to 3E-6 islands per feeder per year***

***Low penetration: 1.5E-17 to 3E-12 islands per feeder per year***

Note: Study assumes over/under voltage and frequency protection only, i.e. no active anti-islanding schemes